

MOSFET - Power, Single N-Channel, μ8FL 30 V, 7.4 mΩ, 47 A NVTFS4C10N

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVTFS4C10NWF Wettable Flanks Product
- NVT Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_{.1} = 25°C unless otherwise stated)

| Parameter | | | Symbol | Value | Unit |
|--|----------------------|---------------------------|--------------------------------------|----------------|------|
| Drain-to-Source Voltage | | | V_{DSS} | 30 | V |
| Gate-to-Source Voltage | | | V_{GS} | ±20 | V |
| Continuous Drain | | T _A = 25°C | I _D | 15.3 | Α |
| Current $R_{\theta JA}$ (Notes 1, 2, 4) | | T _A = 100°C | | 10.8 | |
| Power Dissipation R _{θJA} | | T _A = 25°C | P _D | 3.0 | W |
| (Notes 1, 2, 4) | Steady | T _A = 100°C | | 1.5 | |
| Continuous Drain Current R _{WJC} | State | T _C = 25°C | I _D | 47 | Α |
| (Notes 1, 3, 4) | | T _C = 100°C | | 33 | |
| Power Dissipation | | T _C = 25°C | P_{D} | 28 | W |
| R _{ψJC} (Notes 1, 3, 4) | | T _C = 100°C | | 14 | |
| Pulsed Drain Current | T _A = 25° | C, t _p = 10 μs | I _{DM} | 196 | Α |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | -55 to +175 | °C |
| Source Current (Body Diode) | | | I _S | 53 | Α |
| Single Pulse Drain-to-Source Avalanche Energy $(T_J = 25^{\circ}C, V_{GS} = 10 \text{ V}, I_L = 10.2 \text{ A}, L = 0.5 \text{ mH})$ | | | E _{AS} | 26 | mJ |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | TL | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

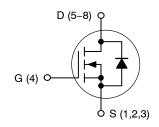
| Parameter | Symbol | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Case (Drain) (Notes 1, 3) | $R_{\psi JC}$ | 5.4 | °C/W |
| Junction-to-Ambient - Steady State (Notes 1, 2) | $R_{\theta JA}$ | 50 | |

- The entire application environment impacts the thermal resistance values shown; they are not constants and are valid for the specific conditions noted.
- 2. Surface-mounted on FR4 board using 650 mm², 2 oz. Cu Pad.
- Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
- 4. Continuous DC current rating. Maximum current for pulses as long as one second is higher but dependent on pulse duration and duty cycle.

1

| V _{(BR)DSS} R _{DS(on)} MAX | | I _D MAX |
|--|---------------|--------------------|
| 30 V | 7.4 mΩ @ 10 V | 47 A |
| 30 V | 11 mΩ @ 4.5 V | 47 A |

N-Channel MOSFET

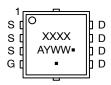






WDFN8 (μ8FL) CASE 511AB WDFNW8 (μ8FL WF) CASE 515AN

MARKING DIAGRAM



4C10 = Specific Device Code for

NVMTS4C10N

WF10 = Specific Device Code of

NVTFS4C10NWF

A = Assembly Location

Y = Year WW = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

| Parameter | Symbol | Test Condition | | Min | Тур | Max | Unit |
|--|-------------------------------------|--|----------------------------|-----|-------|----------|---------|
| OFF CHARACTERISTICS | | | | - | - | <u>-</u> | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | | 30 | | | ٧ |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} / | | | | 14.5 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{GS} = 0 V$, | T _J = 25°C | | | 1.0 | μΑ |
| | | V _{DS} = 24 V | T _J = 125°C | | | 10 | 1 |
| Gate-to-Source Leakage Current | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS}$ | = ±20 V | | | ±100 | nA |
| ON CHARACTERISTICS (Note 5) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D =$ | = 250 μA | 1.3 | | 2.2 | V |
| Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | -4.5 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 30 A | | 5.9 | 7.4 | mΩ |
| | | V _{GS} = 4.5 V | I _D = 15 A | | 8.8 | 11 | |
| Forward Transconductance | 9FS | V _{DS} = 1.5 V, I _D | ₎ = 15 A | | 43 | | S |
| Gate Resistance | R_{G} | T _A = 25° | С | | 1.0 | | Ω |
| CHARGES AND CAPACITANCES | | | | | | | |
| Input Capacitance | C _{ISS} | | | | 993 | | pF |
| Output Capacitance | Coss | V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V | | | 574 | | 1 |
| Reverse Transfer Capacitance | C _{RSS} | | | | 163 | | 1 |
| Capacitance Ratio | C _{RSS} /C _{ISS} | V _{GS} = 0 V, V _{DS} = 15 | V, f = 1 MHz | | 0.164 | | |
| Total Gate Charge | Q _{G(TOT)} | | | | 10.1 | | nC |
| Threshold Gate Charge | Q _{G(TH)} | | | | 1.8 | |] |
| Gate-to-Source Charge | Q_{GS} | $V_{GS} = 4.5 \text{ V}, V_{DS} = 1$ | 5 V; I _D = 30 A | | 2.6 | | |
| Gate-to-Drain Charge | Q_{GD} | | | | 6.1 | |] |
| Gate Plateau Voltage | V_{GP} | 1 | | | 3.2 | | V |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 10 V, V _{DS} = 1 | 5 V; I _D = 30 A | | 19.3 | | nC |
| SWITCHING CHARACTERISTICS (Note 6) | | | | | | | |
| Turn-On Delay Time | $t_{d(ON)}$ | | | | 9.0 | | ns |
| Rise Time | t _r | $V_{GS} = 4.5 \text{ V}, V_{DS}$ $I_{D} = 15 \text{ A}, R_{G}$ | _S = 15 V, | | 30 | | |
| Turn-Off Delay Time | t _{d(OFF)} | $I_D = 15 A, R_G$ | = 3.0 Ω | | 14 | | 1 |
| Fall Time | t _f | 1 | | | 7.0 | | |
| Turn-On Delay Time | t _{d(ON)} | | | | 6.0 | | ns |
| Rise Time | t _r | $V_{GS} = 10 \text{ V, } V_{DS}$ | _S = 15 V, | | 25 | | |
| Turn-Off Delay Time | t _{d(OFF)} | $I_D = 15 \text{ A}, R_G = 3.0 \Omega$ | | | 18 | |] |
| Fall Time | t _f | | | | 4.0 | | |
| DRAIN-SOURCE DIODE CHARACTERIST | cs | | | | | | |
| Forward Diode Voltage | V _{SD} | V _{GS} = 0 V, | $T_J = 25^{\circ}C$ | | 0.80 | 1.1 | V |
| | | I _S = 10 A T _J = 125°C | | | 0.67 | | |
| Reverse Recovery Time | t _{RR} | | | | 23.3 | | ns |
| Charge Time | ta | V _{GS} = 0 V, dlS/dt : | | | 12.7 | | |
| Discharge Time | t _b | I _S = 30 A | | | 10.6 | | <u></u> |
| Reverse Recovery Charge | Q_{RR} | 1 | | | 8.3 | | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

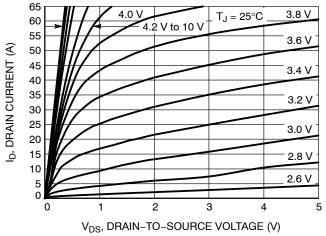


Figure 1. On-Region Characteristics

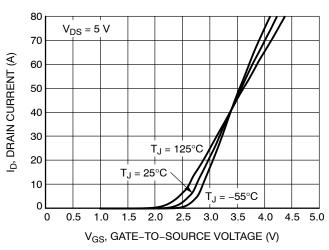


Figure 2. Transfer Characteristics

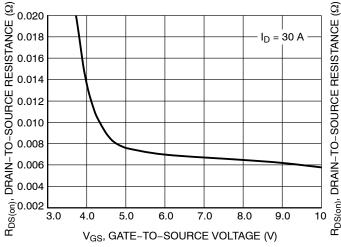


Figure 3. On-Resistance vs. V_{GS}

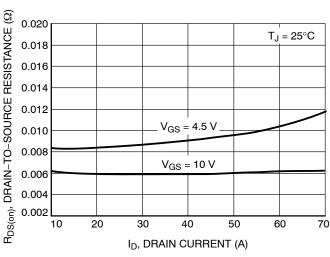


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

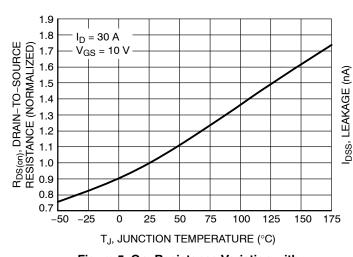


Figure 5. On–Resistance Variation with Temperature

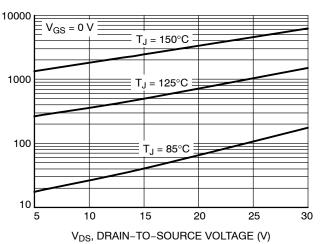


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

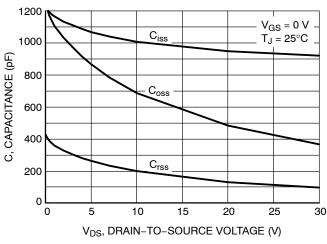


Figure 7. Capacitance Variation

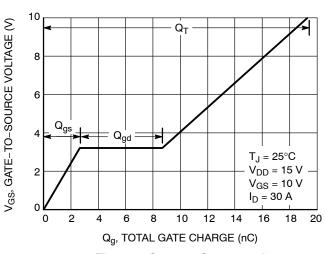


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

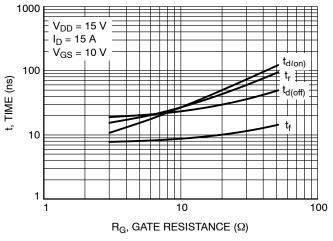


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

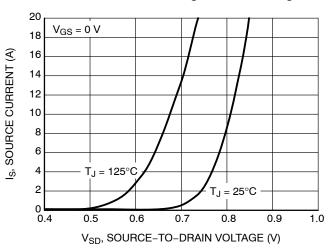


Figure 10. Diode Forward Voltage vs. Current

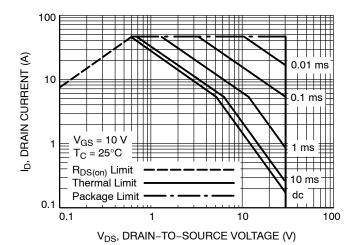


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS

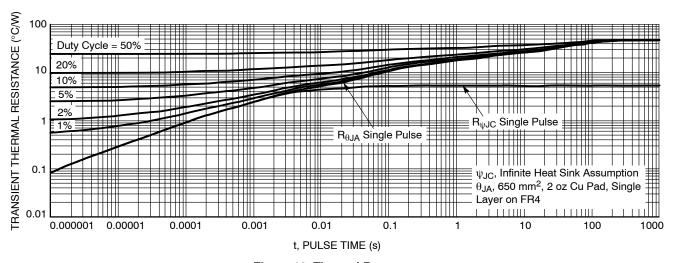


Figure 12. Thermal Response

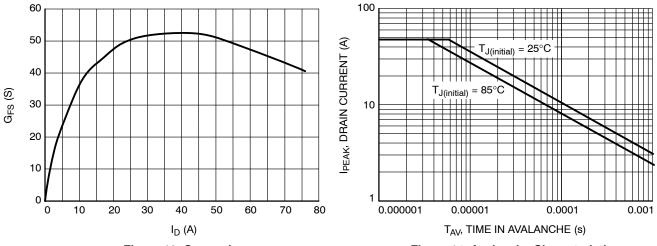


Figure 13. G_{FS} vs. I_D

Figure 14. Avalanche Characteristics

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|-----------------|--------------------------------------|-----------------------|
| NVTFS4C10NTAG | WDFN8 (Pb-Free) | 1500 / Tape & Reel |
| NVTFS4C10NWFTAG | WDFNW8 (Pb-Free, Wettable Flanks) | 1500 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



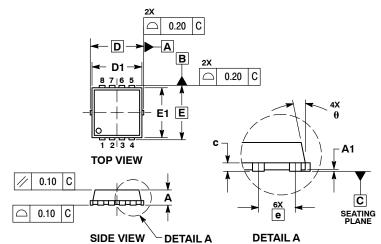




SCALE 2:1

WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

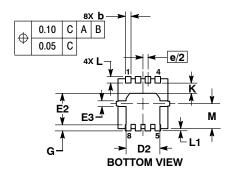
DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

| | MI | LLIMETE | RS | | INCHES | |
|-----|----------|----------|------|-------|----------|-------|
| DIM | MIN | NOM | MAX | MIN | NOM | MAX |
| Α | 0.70 | 0.75 | 0.80 | 0.028 | 0.030 | 0.031 |
| A1 | 0.00 | | 0.05 | 0.000 | | 0.002 |
| b | 0.23 | 0.30 | 0.40 | 0.009 | 0.012 | 0.016 |
| С | 0.15 | 0.20 | 0.25 | 0.006 | 0.008 | 0.010 |
| D | | 3.30 BSC | | C | .130 BSC |) |
| D1 | 2.95 | 3.05 | 3.15 | 0.116 | 0.120 | 0.124 |
| D2 | 1.98 | 2.11 | 2.24 | 0.078 | 0.083 | 0.088 |
| Е | | 3.30 BSC | | C | .130 BSC |) |
| E1 | 2.95 | 3.05 | 3.15 | 0.116 | 0.120 | 0.124 |
| E2 | 1.47 | 1.60 | 1.73 | 0.058 | 0.063 | 0.068 |
| E3 | 0.23 | 0.30 | 0.40 | 0.009 | 0.012 | 0.016 |
| е | 0.65 BSC | | | Ú | 0.026 BS | 2 |
| G | 0.30 | 0.41 | 0.51 | 0.012 | 0.016 | 0.020 |
| K | 0.65 | 0.80 | 0.95 | 0.026 | 0.032 | 0.037 |
| L | 0.30 | 0.43 | 0.56 | 0.012 | 0.017 | 0.022 |
| L1 | 0.06 | 0.13 | 0.20 | 0.002 | 0.005 | 0.008 |
| M | 1.40 | 1.50 | 1.60 | 0.055 | 0.059 | 0.063 |
| θ | 0 ° | | 12 ° | 0 ° | | 12 ° |

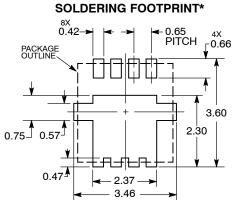


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code Α = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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| DESCRIPTION: | WDFN8 3.3X3.3, 0.65P | | PAGE 1 OF 1 |

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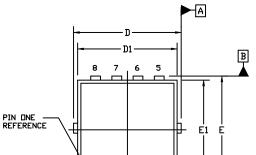
^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.



WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF)

CASE 515AN **ISSUE O**

DATE 25 AUG 2020

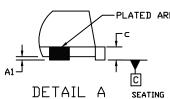


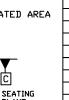
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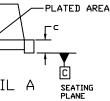
TOP VIEW



- 1. DIMENSIONING AND TOLERANCING PERASME Y14.5M. 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION DI AND EI DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

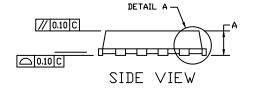




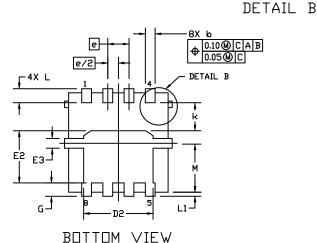


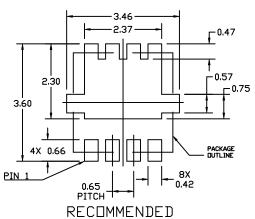


| | MILLIMETERS | | | |
|-----|-------------|----------|------|--|
| DIM | MIN. | NDM. | MAX. | |
| A | 0.70 | 0.75 | 0.80 | |
| A1 | 0.00 | | 0.05 | |
| b | 0.23 | 0.30 | 0.40 | |
| c | 0.15 | 0.20 | 0.25 | |
| D | 3.05 | 3.30 | 3.55 | |
| D1 | 2.95 | 3.05 | 3.15 | |
| D2 | 1.98 | 2.11 | 2.24 | |
| E | 3.05 | 3.30 | 3.55 | |
| E1 | 2.95 | 3.05 | 3.15 | |
| E2 | 1.47 | 1.60 | 1.73 | |
| E3 | 0.23 | 0.30 | 0.40 | |
| e | | 0.65 BSC | | |
| G | 0.30 | 0.41 | 0.51 | |
| K | 0.65 | 0.80 | 0.95 | |
| L | 0.30 | 0.43 | 0.59 | |
| L1 | 0.06 | 0.13 | 0.20 | |
| М | 1.40 | 1.50 | 1.60 | |
| | | | | |









MOUNTING FOOTPRINT For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

GENERIC MARKING DIAGRAM*

XXXX AYWW= XXXX = Specific Device Code

= Assembly Location

= Year WW = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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